


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565742	<b>Applicant(s)/Patent Under Reexamination</b>  VARKI ET AL.
	<b>Examiner</b>  JACOB CHEU	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN EAST	4/12/2009	JC

INTERFERENCE SEARCH			
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